

<b>Notice of References Cited</b>	Application/Control No. 09/675,617	Applicant(s)/Patent Under Reexamination DUNSTAN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,695,999	09-1987	Lebizay, Gerald	370/217
	B	US-5,630,144	05-1997	Woog et al.	713/310
	C	US-5,809,311	09-1998	Jones, Craig Steven	713/300
	D	US-5,842,027	11-1998	Oprescu et al.	713/300
	E	US-5,884,086	03-1999	Amoni et al.	713/300
	F	US-5,978,922	11-1999	Arai et al.	713/323
	G	US-6,105,142	08-2000	Goff et al.	713/324
	H	US-6,148,345	11-2000	Yamaki, Kazunori	709/253
	I	US-6,446,214	09-2002	Chrysanthakopoulos, George	713/310
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 01300742 A	12-1989	Japan	KUSUSE, YASUSHI	H04L 13/00
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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